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Complete List of Authors:	Yan, Zhongna; State key Laboratory of Powder Metallurgy, Central South University Zhang, Dou; Central South University, State Key Laboratory of Powder Metallurgy Zhou, Xuefan; Central South University, State Key Laboratory of Powder Metallurgy Qi, He; Hefei University of Technology, Luo, Hang; Central South University, Zhou, Kechao; Central South University Abrahams, I.; Queen Mary, Chemistry Yan, Haixue; Queen Mary University of London, School of Engineering and Materials Science



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# Silver niobate based lead-free ceramics with high energy storage

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density

Zhongna Yan,<sup>a,b</sup> Dou Zhang,\*<sup>a</sup> Xuefan Zhou,<sup>a</sup> He Qi,<sup>a</sup> Hang Luo,<sup>a</sup> Kechao Zhou,<sup>a</sup> Isaac Abrahams,\*b and Haixue Yan\*c

Antiferroelectrics that display double ferroelectric hysteresis loops have been extensively studied because of their excellent energy storage density compared to normal ferroelectrics and linear dielectrics. Although excellent properties have been achieved in lead-based antiferroelectrics, a feasible replacement for them is urgently needed, with growing concerns on use of lead-containing materials. This work focuses on fabricating AgNbO<sub>3</sub>-based lead-free antiferroelectric ceramics achieved by co-doping of Bi<sup>3+</sup> on the A-site and Zn<sup>2+</sup> on the B-site in AgNbO<sub>3</sub>. These dopants were specifically chosen because of their demonstrated positive influence on energy density and efficiency in AgNbO<sub>3</sub> and other lead-free ferroelectric ceramics. The new AgNbO<sub>3</sub>-based ceramics exhibit a high recoverable energy storage density of 4.6 J/cm<sup>3</sup>, which is one of the highest values for a lead-free ceramic system reported to date. Co-doping of Bi<sup>3+</sup> on the A-site and Zn<sup>2+</sup> on the B-site is found to shift the freezing temperature,  $T_{\rm f}$  to below room temperature stabilizing the antiferroelectric state at room temperature. The increased dielectric breakdown strength,  $E_{\rm b}$ , and electrical displacement,  $D_{\rm m}$ , together with enhanced forward and backward fields are responsible for the high energy storage density. This work shows that a targeted co-doping approach can be an effective strategy for the development of high-performance ceramic capacitors for energy storage applications.

#### 1. Introduction

The development of high pulsed power technologies has allowed for their application in a variety of areas such as power transmission and distribution, aircraft, electric vehicles, and pulsed power weapons.<sup>1-3</sup> Compared to currently available energy storage devices, such as batteries and supercapacitors, dielectric capacitors, with their ultrafast charge/discharge rates and excellent fatigue resistance, are the core components of pulsed power devices.<sup>4-6</sup> However, for applications in energy storage, dielectric capacitors are limited by their low energy storage density.7 Enhancements in energy storage density of the constituent dielectric material would allow for reductions in volume and weight of these devices.7-9

The recoverable energy storage density ( $W_{rec}$ ) of a dielectric material is given by:<sup>10</sup>

$$W_{\rm rec} = \int_{D_{\rm r}}^{D_{\rm m}} E dD \tag{1}$$

where  $D_m$ ,  $D_r$ , and E are the maximum electrical displacement, remnant electrical displacement and applied electric field, respectively. Thus, large  $D_m$ , small  $D_r$  and large E are necessary to obtain high energy density suitable for energy storage applications. A schematic illustration of the energy storage mechanism for antiferroelectrics is given in the supporting information as Figure S1. Generally, dielectric materials for energy storage are divided into four types: linear dielectrics, normal ferroelectrics (FEs), relaxor ferroelectrics and antiferroelectrics (AFEs).<sup>11</sup> Amongst these, AFEs display double hysteresis loops in their electric displacement-electric field diagrams, with characteristics of large  $D_{\rm m}$  and small  $D_{\rm r}$  and are considered to be one of the best candidates for energy storage applications.<sup>12</sup> For AFEs, increasing both the forward field  $E_{\rm F}$ (from AFE to FE) and the backward field  $E_{\rm B}$  (from FE to AFE) are also crucial in enhancing energy storage density.<sup>13</sup>

La-doped lead zirconium titanate ceramics exhibit the highest known  $W_{rec}$  for a ceramic of 6.4 J/cm<sup>3.14</sup> However, due to growing concerns in recent years, associated with environmental protection and human health, a suitable replacement for lead-containing materials is urgently needed.<sup>11,15</sup> Various lead-free systems have been explored such as those based on Bi<sub>0.5</sub>Na<sub>0.5</sub>TiO<sub>3</sub> (BNT),<sup>16</sup> BaTiO<sub>3</sub> (BT),<sup>17</sup>  $K_{0.5}Na_{0.5}NbO_3$  (KNN)<sup>18</sup> and  $KTa_{1-x}Nb_xO_3$  (KTN).<sup>19</sup> AgNbO<sub>3</sub> is a lead-free AFE ceramic that displays double ferroelectric hysteresis loops, with a large field induced polarization (52.0  $\mu$ C/cm<sup>2</sup>) under high electric field (220 kV/cm), resulting in excellent energy storage performance.<sup>20</sup> However, there are

<sup>&</sup>lt;sup>a.</sup> State Key Laboratory of Powder Metallurgy, Central South University, South Lushan Road, Changsha, 410083, Hunan Province, China. E-mail: dzhang@csu.edu.cn

<sup>&</sup>lt;sup>b.</sup> School of Biological and Chemical Sciences, Queen Mary University of London, Mile End Road, London, E1 4NS, UK. E-mail: i.abrahams@qmul.ac.uk

<sup>&</sup>lt;sup>c</sup> School of Engineering and Materials Sciences, Queen Mary University of London, Mile End Road, London, E1 4NS, UK. E-mail: h.x.yan@qmul.ac.uk

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still many open questions regarding details of the local structure and phase transitions in AgNbO<sub>3</sub>, including the nature of the freezing temperature  $T_{\rm f}$ .<sup>10,21</sup>

A-site doping is a method for altering the value of  $D_m$ , for example, in the case of Bi<sup>3+</sup> or Pb<sup>2+</sup> doping, large values of  $D_m$ can be achieved, which has been explained by hybridization between Bi or Pb 6s and O 2p orbitals.<sup>22-25</sup> Tian *et al.* reported that A-site doping by Bi<sup>3+</sup> can lead to an enhancement of antiferroelectricity in AgNbO<sub>3</sub>-based ceramics and the  $T_f$  can be lowered to below room temperature with increasing dopant concentration.<sup>21</sup> Zhao *et al.* reported that the AFE performance of AgNbO<sub>3</sub> ceramics can be significantly enhanced by incorporating Mn<sup>4+</sup>, Ta<sup>5+</sup> or W<sup>6+</sup> on the B-site,<sup>13,26,27</sup> indicating that  $E_F$  and  $E_B$  can be increased in AgNbO<sub>3</sub> ceramics through B site doping.

When used as a B-site dopant, Zn2+, has been shown to successfully increase field induced electrical displacement in other perovskite based ferroelectric ceramics such as Bi<sub>0.5</sub>Na<sub>0.5</sub>TiO<sub>3</sub> and BaTiO<sub>3</sub>;<sup>28,29</sup> to the best of our knowledge, the effects of Zn<sup>2+</sup> doping into AgNbO<sub>3</sub> have not been investigated. We have previously shown that A-site doping by Bi<sup>3+</sup> in AgNbO<sub>3</sub> successfully increases energy density and efficiency.<sup>21</sup> In this work, we use a strategy of simultaneous A and B site doping of AgNbO<sub>3</sub> by  $Zn^{2+}$  to increase  $D_m$  and  $Bi^{3+}$  to shift  $E_F$  and  $E_B$  to higher electric field, and adjust  $T_{f}$  to below room temperature. The new solid solution system (1-x)AgNbO<sub>3</sub>-xBi(Zn<sub>2/3</sub>Nb<sub>1/3</sub>)O<sub>3</sub> presented here is specifically designed to achieve high energy storage density. This targeted approach has yielded a material with a recoverable energy storage density of 4.6 J/cm<sup>3</sup>, which is one of the highest known values reported for a lead-free ceramic system to date.

#### 2. Experimental

(1-x)AgNbO<sub>3</sub>-xBi(Zn<sub>2/3</sub>Nb<sub>1/3</sub>)O<sub>3</sub> (x = 0.000, 0.005, 0.010 and 0.030) ceramics, abbreviated as (1-x)AN-xBZN, were obtained by a conventional solid-state reaction method. Stoichiometric amounts of Ag<sub>2</sub>O (99.7%), Nb<sub>2</sub>O<sub>5</sub> (99.99%), ZnO (99%) and Bi<sub>2</sub>O<sub>3</sub> (99.9%) were ground in anhydrous ethanol for 24 h using a planetary ball mill at 280 rpm in a nylon jar. After drying, the blended powders were calcined at 850 °C in a tube furnace for 6 h in flowing O<sub>2</sub>. The calcined powders were re-milled for 24 h in anhydrous ethanol. After drying, they were blended with 5 wt% PVA solution and were pressed into disks of 12 mm diameter and 1.0-1.5 mm thickness under 180 MPa for 1.5 min. After burning off the PVA at 600 °C for 2 h, the disks were sintered at temperatures between 1070 - 1110 °C for 6 h in flowing  $O_2$ , followed by cooling to room temperature. The heating/cooling rate and the O<sub>2</sub> flow rate were 5 °C/min and 0.5 L/min, respectively.

The density of the sintered samples was measured by the Archimedes method in water. The morphology of polished and thermally etched (at 1130 °C for 30 min) surfaces was observed by field emission scanning electron microscopy (FESEM, Nova NanoSEM230, USA) and grain size measurements made using the Image J software.<sup>30</sup> X-ray powder diffraction (XRD, D8 Advance, Bruker) was used to determine the phase structure

using Cu-K $\alpha$  radiation ( $\lambda$  = 1.5418 Å). Raman spectra were measured using a LabRAM HR800 spectrometer (Horiba JobinYvon, Paris, France). Transmission electron microscopy (TEM) images and selected-area electron diffraction (SAED) patterns of the samples were recorded using a Titan G2 60-300 electron microscope (FEI, USA), with energy dispersive spectroscopy (EDS) carried out using an EDS system (Oxford Instruments, UK) on the same microscope. For the TEM characterization, the samples were mechanically ground and polished down to 60 µm in thickness, followed by ion thinning to electron transparency. Piezoelectric force microscopy (PFM) measurements were performed using an atomic force microscope (NanoManTM VS) with a conductive Pt/Ir-coated Si cantilever (SCM-PIT). For the PFM measurements, samples were ground and polished down to a thickness of 80 µm and polarized in advance under an electric field of 100 kV/cm. Measurements were performed using a tip bias voltage of 12 V.

For electrical characterization, Ag electrodes were applied and fired on both parallel surfaces of the samples. The temperature dependent permittivity was measured using an LCR meter (Agilent E4980A) connected to a computercontrolled furnace from 1 kHz to 1 MHz on heating and cooling. The frequency dependent permittivity was measured using an LCR meter (Agilent 4284A) at room temperature. The electric displacement-electric field (D-E) and current- electric field (I-E) hysteresis loops for these samples with Ag electrodes (2-3 mm in diameter) on both parallel surfaces were measured in silicone oil using a ferroelectric measurement system (aixACCT, TF Analyzer2000, Germany) at 1 Hz. The samples were lapped down to a thickness of ca. 0.23 mm for the low and high electric field D-E loop measurements to study the phase transitions induced by the electric field. The differential permittivity (dD/dE) versus electric field loops were obtained from the D-E loops. The values of breakdown strength were analysed with a two-parameter Weibull distribution function using the following equation: <sup>31</sup>

$$P(E) = 1 - \exp[-(E_{\rm b}/E_0)^{\beta}]$$
(2)

where P(E) is the cumulative probability of electric failure,  $\beta$  is a shape parameter, and  $E_0$  represents the characteristic breakdown strength required for 63.2% of the tested samples to fail.

#### 3. Results and discussion

#### 2.1 Structural characterization

SEM images of (1- *x*)AN-*x*BZN ceramics are shown in Figure 1ad. All ceramics possess dense microstructures with relative densities above 95%. The average grain size decreases with increasing dopant level, Figure 1a1-d1. While this phenomenon has been seen before in AgNbO<sub>3</sub>-based ceramics,<sup>26</sup> in the present case it is likely due to the lower sintering temperatures used for the doped samples (1100 °C for pure AN, 1090 °C for *x* = 0.005 and *x* = 0.010, and 1070 °C for *x* = 0.030). The TEM EDX mapping images of the *x* = 0.010 composition (Figure S2) show a uniform distribution of the constituent elements Ag, Bi, Nb, Zn and O.

(3)

Figure 2a shows the XRD patterns of crushed pellets of the studied ceramics, with detail of the weaker reflections shown in Figure 2b-e. The patterns are in good agreement with those of

is maintained through a balance of substitutional point defects rather than vacancies or interstitials (Equation 3).

$$3Ag_{Ag}^{X} + 2Nb_{Nb}^{X} \xrightarrow{Bi,Zn} 3Bi_{Ag}^{\bullet\bullet} + 2Zn_{Nb}^{\prime\prime\prime}$$



**Figure 1** (a-d) SEM images and (a1-d1) grain size distributions of (1-*x*)AN-*x*BZN ceramics. Grain sizes were measured from 100 randomly selected grains in the corresponding SEM image.

AgNbO<sub>3</sub> (PDF #70-4738). There are very small changes in the unit cell parameters (Figure S3). While there is a slight general decrease in *a* and *b* parameters from x = 0.000 to x = 0.030, the *c*-parameter increases over this range, giving an overall increase in volume at x = 0.030 compared to pure AgNbO<sub>3</sub>. These very small changes in lattice parameters are to be expected, not only because of the low levels of substitution, but also due to the fact that while the ionic radius of Zn<sup>2+</sup> is larger than that of Nb<sup>5+</sup> (r = 0.74 Å and 0.64 Å, respectively for the ions in 6 coordinate geometry), the ionic radius of Bi<sup>3+</sup> is smaller than that of Ag<sup>+</sup> (r = 1.17 Å and 1.28 Å, respectively for the ions in 8 coordinate geometry).<sup>32</sup> For the x = 0.030 composition this would equate to an overall change in volume of 0.05%, compared to unsubstituted AgNbO<sub>3</sub>, which is close to the observed value of

Rietveld analysis was used to investigate the room temperature structure of the x = 0.010 composition. As discussed in the work of Tian *et al.*,<sup>10</sup> both polar and non-polar models were tested in space groups  $Pb2_1m$  and Pbcm, respectively. The fitted diffraction profiles for these two models are compared in Figure S4. Both models, fit the data well, with similar reliability factors. Bearing in mind the increased number of parameters in the  $Pb2_1m$  model, it does not offer a significantly improved fit over the *Pbcm* model, generating similar reliability factors. Thus it may be concluded that the average structure is adequately described as being centrosymmetric i.e. AFE. Bright-field TEM images and selectedarea electron diffraction (SAED) patterns of the x = 0.010composition viewed along the [001], [100], [22-1], and [04-1]



**Figure 2** XRD patterns of (1-*x*) AN-*x*BZN crushed ceramics: (a) full patterns and (b) to (e) detail of weaker reflections. Miller indices corresponding to the *Pbcm* cell are shown with reflection positions indicated by markers in (a).

0.06%. The solid solution formula is such that electroneutrality zone axes of the orthorhombic cell are shown in Figure 3.

Crystallites are seen to be multi-domain and composed of micron-sized domain blocks, Figure 3a-c. Although the average structure from the Rietveld analysis is centrosymmetric, it has been reported that in AgNbO<sub>3</sub> lower symmetry FE regions (*Pb*2<sub>1</sub>*m*) within the average AFE matrix may exist.<sup>10, 13, 33</sup> In general, the appearance of (*hOl*) or (*OOl*) reflections with l = 2n + 1 in SAED images indicates the existence of the polar phase. The (003) reflection, as indicated by the red arrows in Figure 3e and 3g, is clear evidence for the presence of the *Pb*2<sub>1</sub>*m* polar phase. Therefore, while the majority of the crystallites in the *x* = 0.010 ceramic are non-polar, low concentrations of polar crystallites appear to be present.

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Generally, the phase stability of a perovskite structure can be evaluated according to the perovskite tolerance factor (t), which is given by equation 4, where  $R_A$ ,  $R_B$ , and  $R_O$  are the ionic radii of A-and B-site cations, and the oxygen anion, respectively.<sup>34</sup>



Figure 3 TEM images of 0.99AN-0.01BZN ceramics: (a)-(c) overview bright-field images showing the domains; (d) SAED patterns taken from the domain labeled ① in (a); (e)-(g) SAED patterns taken from the domains labeled ②-⑤ in (b); (h) SAED patterns taken from the domains labeled ⑥ in (c).

$$t = \frac{R_{\rm A} + R_{\rm 0}}{\sqrt{2}(R_{\rm B} + R_{\rm 0})} \tag{4}$$

The FE phase is stabilized when t > 1, while the AFE phase is stabilized when t < 1. The substitution of Bi<sup>3+</sup> for Ag<sup>+</sup>, and Zn<sup>2+</sup> for Nb<sup>5+</sup> gives t values in the range 0.7999 to 0.8007 for the studied compositions, which is in the range of AFE phase stability.

Figure 4 shows the fitted Raman spectra of the studied (1x)AN-xBZN ceramics. The spectrum of the x = 0.000 composition is in good agreement with those in previous studies.<sup>35</sup> Low wavenumber bands are associated with vibrations of the Nb<sup>5+</sup> and Ag<sup>+</sup> cations (< 92 cm<sup>-1</sup> and 200 to 350 cm<sup>-1</sup>) and tilting of the NbO<sub>6</sub> octahedra at around 105 cm<sup>-1</sup>. The higher wavenumber bands are associated with bending and stretching modes  $v_1$ ,  $v_2$ ,  $v_4$ ,  $v_5$  of the NbO<sub>6</sub> octahedra. On substitution of Ag<sup>+</sup> by Bi<sup>3+</sup> and Nb<sup>5+</sup> by Zn<sup>2+</sup>, all bands weaken and broaden until at x = 0.030



Figure 4 Fitted Raman spectra of (1-x)AN-xBZN ceramics.

only very broad features are seen in the spectrum.

Spectral broadening such as that seen can be attributed to increasing disorder in the system with increasing level of substitution and is consistent with the observed general increase in unit cell volume. This would be expected to result in an increasing range of low symmetry environments for the B site cations with increasing x-value. Similar behaviour was observed in the  $AgNb_{1-x}Ta_xO_3$  system, where it was attributed to the lower polarizability of the substituting cation as well as a reduction in the correlation length of the displacements.<sup>13</sup> In the present case, while the polarizability of Zn<sup>2+</sup> (1.29 Å<sup>3</sup>) is very much lower than that of Nb<sup>5+</sup> (3.10 Å<sup>3</sup>), that of  $Bi^{3+}$  (3.95 Å<sup>3</sup>) is much larger than that of Ag<sup>+</sup> (1.78 Å<sup>3</sup>),<sup>29</sup> making the B-site cations on average less sensitive to the applied electric field. In Raman spectra this change in polarizability has the effect of weakening or enhancing modes. This is clearly visible in the E mode of the x = 0.030 composition, associated with tilting of the niobate octahedra, which is significantly weakened with respect

to other modes. This suggests that the structure of this composition is above its  $T_{\rm f}$  temperature.

**Table 1** Raman shift and possible assignment of phonon modes of  $AgNbO_3$  at room temperature.

Phonon	Raman shift	Assignment	Reference	
mode	[cm <sup>-1</sup> ]	Assignment		
А	52.7	Ag <sup>+</sup> /Nb <sup>5+</sup>	36, 37	
В	66.1	Ag <sup>+</sup> /Nb <sup>5+</sup>	36, 37	
С	79.5	Ag <sup>+</sup> /Nb <sup>5+</sup>	36, 37	
D	91.4	Ag+	20, 37	
E	104.8	NbO <sub>6</sub> tilting	36	
F	141.7	?	35	
G	218.5	?	35	
н	253.8	E <sub>g</sub> (Nb) + A <sub>1g</sub> (Nb)	35, 37	
I	349.5	Nb <sup>5+</sup>	35	
J	410.0	$T_{2g}$ ( $\upsilon_{5}$ ) and/or $T_{1u}$ ( $\upsilon_{4}$ )	35 <i>,</i> 36	
К	523.6	$E_g(v_2)$	35	
L	569.0	$A_{\mathtt{1g}}$ ( $\upsilon_{\mathtt{1}}$ ) and $E_{g}$ ( $\upsilon_{\mathtt{2}}$ )	35	
М	803.5	A <sub>1g</sub> ( <i>υ</i> <sub>1</sub> )	35	

#### 2.2 Dielectric response

Figure 5a-d shows the temperature dependence of relative permittivity and dielectric loss of (1-x)AN-xBZN ceramics over the frequency range 10 kHz to 1 MHz, from ambient temperature up to 500 °C on heating. Plots for sub-ambient temperatures are given in the supporting information as Figure S5. Several dielectric anomalies can be observed in Figure 5a, corresponding to the known phase transitions of pure AgNbO<sub>3</sub>.<sup>20</sup> Dielectric anomalies at ca. 50 °C and ca. 260 °C are associated with the  $M_1 \rightarrow M_2$  and  $M_2 \rightarrow M_3$  phase transitions, respectively, which maintain the  $(a^-, b^-, c^+)/(a^-, b^-, c^-)$  octahedral tilting system throughout,<sup>38</sup> although the nature of these transitions is not yet fully understood.<sup>10, 38</sup> An anomaly in the dielectric loss spectrum at ca. 170 °C, that has only a very weak corresponding feature in the permittivity spectrum is ascribed to the freezing temperature,  $T_{\rm f}$  (the critical temperature where the antipolar dipoles are frozen as cations order).<sup>38, 39</sup> The jump to a permittivity maximum near 350 °C, followed by a shoulder at around 400 °C are attributed to the Pbcm  $\rightarrow$  Cmcm and Cmcm  $\rightarrow$  to P4/mbm phase transitions, respectively. These involve changes in the octahedral tilting system of  $(a^{-}, b^{-}, c^{+})/(a^{-}, c^{+})$  $b^-$ ,  $c^-$ )  $\rightarrow$  ( $a^0$ ,  $b^-$ ,  $c^+$ )  $\rightarrow$  ( $a^0$ ,  $b^0$ ,  $c^+$ ), respectively.<sup>38</sup> Apart from that



**Figure 5** (a-d) Temperature dependence of relative permittivity and dielectric loss of (1-*x*)AN-*x*BZN ceramics from 10 kHz to 1MHz, (e) Phase diagram plotted at 1 kHz, (f) BZN concentration dependence of relative permittivity of (1-*x*)AN-*x*BZN ceramics plotted from frequency dependence of relative permittivity before and after poling at 1 MHz.

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associated with the Cmcm  $\rightarrow$  to P4/mbm transition, all dielectric anomalies show a general decrease in temperature with increasing x-value (Figure 5e), with the  $M_1 \rightarrow M_2$  transition shifting to below room temperature. For the x = 0.030composition, T<sub>f</sub> is also shifted to below room temperature. Thus at ambient temperature, AgNbO<sub>3</sub> is present as the M<sub>1</sub> phase, while the doped compositions are in the M<sub>2</sub> phase either below  $T_{\rm f}$  (x = 0.005 and 0.010) or above  $T_{\rm f}$  (x = 0.030). Figure 5f shows the changes in relative permittivity before and after poling. For all samples, the relative permittivity increased with increasing x-value. For the x = 0.000 and x = 0.005 compositions, relative permittivity shows a small decrease after successive polarization under low (60 kV/cm) and high electric fields (140 kV/cm). In contrast, at x = 0.030 the relative permittivity increased on successive polarization under low and high electric fields. In the case of the x = 0.010 composition, intermediate behaviour is observed, with a decrease in relative permittivity on initial polarization at low field, followed by an increase at high field. The same trends were observed in multiple samples of the different compositions.

## **2.3** Electrical polarization response and energy storage performance

Figure 6 shows the low field (60 kV/cm) ferroelectric D-E and I-E loops measured at 1 Hz for (1-x)AN-xBZN ceramics. In agreement with the findings of Tian et al.,<sup>10</sup> two current peaks at  $E_1 \approx 3$  kV/cm and  $E_2 \approx 25$  kV/cm are observed in the *I*-E loop of the AgNbO<sub>3</sub> ceramic (Figure 6a), which have been attributed to FE domain switching behaviour and the field induced transition from ferrielectric (FIE) to ferroelectric states.<sup>21,38</sup> These current peaks gradually diminish with increasing *x*-value. Indeed, the  $E_1$  peak is no longer evident in the *I*-*E* loop of the x = 0.005 composition (Figure 6b), while the  $E_2$  peak, which is related to the field induced polar phase, broadens and shifts to lower field with increasing x-value, eventually disappearing at x = 0.030. Thus co-doping of AgNbO<sub>3</sub> appears to decrease the  $T_{\rm f}$ temperature as previously noted for Bi doped AgNbO<sub>3</sub>.<sup>21</sup> However, the D<sub>max</sub> gradually increases with increasing doping level, which suggests that Zn doping causes an increase in the field induced electric displacement in the doped compositions. This is likely to be associated with a greater field induced distortion. Similar effects were observed in Zn2+ doped Bi<sub>0.5</sub>Na<sub>0.5</sub>TiO<sub>3</sub> and BaTiO<sub>3</sub>.<sup>28, 29</sup>



Figure 6 Low electric field ferroelectric D-E and I-E loops measured at 1 Hz for (1-x)AN-xBZN ceramics.

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Figure 7 High electric field ferroelectric D-E (a and d) and dD/dE-E loops (b, c, e, and f) measured at 1 Hz for (1-x)AN-xBZN ceramics.

As discussed above, doping causes  $T_{\rm f}$  to shift to lower temperature. Therefore, for the x = 0.030 composition, the M<sub>2</sub> phase present at room temperature is above the dipole freezing temperature, while for the x = 0.005 and 0.010 compositions the  $M_2$  phase present at room temperature is below  $T_f$ . In undoped AgNbO<sub>3</sub>, the decrease in relative permittivity on poling may be attributed to a decrease in FE domain wall density after being poled under DC field. As the concentration of FE domains decreases with increasing x-value, poling eventually results in an increase in permittivity as it induces the growth of new polar regions within a predominantly AFE matrix.<sup>40</sup> For the x = 0.010composition, the initial decrease in permittivity is attributed to the decrease in FE domain wall density, while the increase in permittivity at higher field arises from field induced ferrielectric regions. Indeed, it is known that a strong  $E_2$  peak can be induced at high field in AgNbO<sub>3</sub>.<sup>10</sup> The *I*-*E* loop of the x = 0.030composition exhibits near linear dielectric behaviour, which suggests that the structure of the room temperature phase (i.e. above  $T_{\rm f}$ ) is AFE and agrees with the lack of current peaks associated with domain switching events  $(E_1)$  and the field induced ferrielectric phase  $(E_2)$  in the *I*-*E* loop (Figure 6d).

The low field phase transition of the studied ceramics can be further characterized by the piezoresponse (PR) phasevoltage hysteresis and amplitude-voltage loops (Figure S6). Local butterfly with two minima and phase angle loops for the undoped material are characteristic of FE behavior.<sup>41</sup> Similar loops are seen for the x = 0.005 composition, confirming a significant FE contribution. As the dopant level increases, the FE contribution diminishes and hysteresis is minimized. V shaped curves are still observed, but now with a single minimum, corresponding to field induced polarization changes due to the higher applied field of the PFM tip.

Figure 7 exhibits the high electric field ferroelectric *D-E* and dD/dE-*E* loops of the as-prepared ceramics. Compositions with  $x \le 0.010$  show double-like hysteresis loops, typical of AFE or AFE-like behaviour. Four sharp peaks are clearly seen in the dD/dE-*E* loops of compositions with  $x \le 0.010$ , as previously seen for the undoped AgNbO<sub>3</sub> ceramic;<sup>21</sup> two peaks, denoted  $\pm E_F$  at higher field represent the electric forward field, at which the initial state is converted to the ferroelectric state, while two peaks at lower field denoted  $\pm E_B$ , represent the electric backward field at which the FE state is converted to the AFE state. In contrast, the x = 0.030 composition exhibits a near-linear hysteresis loop and the dD/dE-*E* loop shows no significant current peaks, suggesting much higher fields are required to drive the transition from AFE to FE states.

Table 2 summarizes the energy storage properties of the studied ceramics. With increasing *x*-value the electric field induced transition peaks  $E_{\rm F}$  and  $E_{\rm B}$  shift to higher electric field, consistent with the inhibition of local polar ordering by doping, resulting in the favouring of the AFE state.<sup>21,38</sup> Additionally, the difference ( $\Delta E$ ) between  $E_{\rm F}$  and  $E_{\rm B}$  decreases with increasing *x*-value, which is favourable for higher efficiency in energy storage. Close inspection of the dD/dE-E loops reveals weak peaks at around  $\pm$  50 kV/cm denoted  $\pm E_{\rm U}$ . These have previously been observed in the parent compound, but their exact origin remains unclear.

Samples	D <sub>m</sub> [μC/cm²]	D <sub>r</sub> [μC/cm²]	E <sub>F</sub> [kV/cm]	E <sub>B</sub> [kV/cm]	<i>∆E</i> [kV/cm]	E <sub>max</sub> [kV/cm]	W <sub>rec</sub> [J/cm <sup>3</sup> ]	η [%]
AN	37.3 ± 0.1	3.6 ± 0.1	158 ± 0.5	47 ± 0.5	111 ± 0.5	180	$1.9 \pm 0.1$	35.2 ± 0.1
0.995AN-0.005BZN	59.3 ± 0.1	$11.3 \pm 0.1$	178 ± 0.5	69 ± 0.5	109 ± 0.5	210	$3.3 \pm 0.1$	31.2 ± 0.1
0.99AN-0.01BZN	53.8 ± 0.1	$7.0 \pm 0.1$	$198 \pm 0.5$	$118 \pm 0.5$	80 ± 0.5	220	$4.6 \pm 0.1$	57.5 ± 0.1
0.97AN-0.03BZN	$42.4 \pm 0.1$	$5.3 \pm 0.1$	-	-	-	230	3.7 ± 0.1	$68.1 \pm 0.1$

Table 2 Energy storage properties of (1-x)AN-xBZN ceramics.

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Average  $E_b$  values determined from the fitted Weibull plots (Figure S7a)<sup>31</sup> are in good agreement with the  $E_{max}$  values in Table 2. The improvement in  $E_b$  with increasing x-value is possibly due to the reduced grain size. Indeed, Tunkasiri *et al.* proposed an empirical relationship between grain size in the micron range and dielectric breakdown strength in BaTiO<sub>3</sub> ceramics:<sup>42</sup>

$$E_{\rm b} \propto \frac{1}{\sqrt{G}} \tag{5}$$

where *G* is the grain size. Similar results were also reported in MgO ceramics with smaller grains of sub-micron size by Beauchamp *et al.*.<sup>43</sup> As seen in Figure S7b, there is a reasonable correlation between  $E_b$  and grain size in the present system.

The maximum electric displacement,  $D_m$ , increases from 37.3  $\mu$ C/cm<sup>2</sup> for pure AgNbO<sub>3</sub> to 59.3  $\mu$ C/cm<sup>2</sup> for the x =0.005 composition and then decreases with increasing dopant level

As seen in Table 2, the doped ceramics show enhanced energy storage density, compared to undoped AgNbO<sub>3</sub>, mainly due to the increased dielectric breakdown strength. The maximum  $W_{\rm rec}$  of 4.6 J/cm<sup>3</sup> is achieved for the x = 0.010 composition, due to the increased  $E_{\rm F}$  and  $E_{\rm B}$  values as well as the large  $D_{\rm m}$  (53.8 µC/cm<sup>2</sup>) value (Figure 8a).

The energy storage efficiency  $\eta$  can be calculated as follows:

$$\eta = \frac{W_{\rm rec}}{W_{\rm rec} + W_{\rm loss}} \tag{6}$$

where the recoverable energy density ( $W_{rec}$ ) and energy density loss ( $W_{loss}$ ) are represented by the blue and the light brown areas, respectively (Figure S1). In this work, the  $\eta$  values show an increasing trend with increasing *x*-value as shown in Figure 8a. Amongst the studied compositions the best overall energy storage performance is shown by the x = 0.010 composition,



**Figure 8** (a) Energy storage density (*W*) and efficiency ( $\eta$ ) of (1-*x*)AN-*x*BZN ceramics and (b) comparison of recoverable energy density ( $W_{rec}$ ) in 0.99AN-0.01BZN ceramic with that in other reported lead-free systems: ( $K_{0.5}Na_{0.5}$ )NbO<sub>3</sub>-based (Qu *et al.*,<sup>45</sup> and Shao *et al.*<sup>24</sup>), BaTiO<sub>3</sub>-based (Wu *et al.*,<sup>46</sup> Wang *et al.*,<sup>47</sup> and Yuan *et al.*<sup>48</sup>), Bi<sub>0.5</sub>Na<sub>0.5</sub>TiO<sub>3</sub>-based (Li *et al.*,<sup>49</sup> Xu *et al.*,<sup>50</sup> Ding *et al.*,<sup>51</sup> and Gao *et al.*<sup>52</sup>), (Ba<sub>0.4</sub>Sr<sub>0.6</sub>)TiO<sub>3</sub>-based (Song *et al.*,<sup>53</sup> and Zhang *et al.*<sup>54</sup>), and AgNbO<sub>3</sub>-based (Tian *et al.*,<sup>10, 21</sup> and Zhao *et al.*<sup>13, 27</sup>).

(Figure 7a Table 2). The same trend is seen for the remnant electric displacement ( $D_r$ ), increasing from 3.6  $\mu$ C/cm<sup>2</sup> for pure AgNbO<sub>3</sub> to 5.3  $\mu$ C/cm<sup>2</sup> for the x = 0.030 composition, with a maximum value of 11.3  $\mu$ C/cm<sup>2</sup> for the x = 0.005 composition. Compared to the lower field measurements, at high field,  $D_r$  increases in all samples. For compositions below x = 0.030 this can be attributed to the strong transition from FIE to FE states below  $T_f$ . In the case of the x = 0.030 composition, Figure 7f shows a sharp current peak at the highest field, suggesting the change in  $D_r$  is associated with a conductivity contribution.<sup>44</sup> The difference ( $\Delta D$ ) between the maximum electrical displacement ( $D_r$ ) is higher than that of pure AgNbO<sub>3</sub> for all the doped compositions.

with a high  $W_{rec}$  value of 4.6 J/cm<sup>3</sup> and  $\eta$  of 57.5%. The maximum energy storage density achieved in this ceramic is higher than in almost any other lead-free ceramic reported to date (Figure 8b) including KNN, BT, BNT, BST and AN based materials, and is 2.4 times larger than that of pure AgNbO<sub>3</sub>. This high energy density is obtained at a lower field than that required to achieve similar energy densities in KNN based ceramics. These features make Bi,Zn co-doped AgNbO<sub>3</sub> ceramics a potential candidate for energy storage applications.

#### Conclusions

In this work, increasing dopant concentration and decreasing grain size lead to improvements in dielectric breakdown strength. This allows for a higher applied electric field, which is

beneficial to the improvement of the energy storage density. A large recoverable energy density of 4.6 J/cm<sup>3</sup>, which is 2.4 times larger than that of pure AgNbO<sub>3</sub>, has been achieved in 0.99AN-0.01BZN ceramic. Co-doping of Bi<sup>3+</sup> and Zn<sup>2+</sup> into AgNbO<sub>3</sub> stabilizes AFE behaviour, with the non-polar Pbcm phase dominant for the 0.99AN-0.01BZN ceramic. This stability can be explained by the decrease of the freezing temperature  $T_{\rm f}$  to below room temperature. The enhanced maximum electrical displacement  $(D_m)$  is proposed to be due to the  $Zn^{2+}$  doping on the B-site and is likely to be associated with greater field induced distortion. The increased forward and backward electric fields ( $E_F$  and  $E_B$ ), as well as the enhanced maximum electrical displacement  $(D_m)$  are responsible for the improved energy storage properties, making the (1-x)AN-xBZN solid solution a promising lead-free candidate for high performance ceramic capacitors for energy storage applications.

#### **Conflicts of interest**

There are no conflicts of interest to declare.

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